Search Notes

Application/Control No.	Applicant(s)/Patent ur Reexamination	nder
10/720,838	GROS-JEAN ET AL.	
Examiner	Art Unit	
R Chen	1762	

SEARCHED					
Class	Subclass	Date	Examiner		
427	255.29 255.31	6/4/2006	вс		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
east	6/4/2006	вс		
STIC	6/4/2006	вс		